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### Understanding <u>Embedded - CPLDs (Complex</u> <u>Programmable Logic Devices)</u>

Embedded - CPLDs, or Complex Programmable Logic Devices, are highly versatile digital logic devices used in electronic systems. These programmable components are designed to perform complex logical operations and can be customized for specific applications. Unlike fixedfunction ICs, CPLDs offer the flexibility to reprogram their configuration, making them an ideal choice for various embedded systems. They consist of a set of logic gates and programmable interconnects, allowing designers to implement complex logic circuits without needing custom hardware.

#### **Applications of Embedded - CPLDs**

### Details

Obsolete
In System Programmable
7.5 ns
3V ~ 3.6V
16
256
5000
164
0°C ~ 70°C (TA)
Surface Mount
256-BGA
256-FBGA (17x17)
https://www.e-xfl.com/product-detail/intel/epm7256aefc256-7

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Table 1. MAX 700	IOA Device Featur	es			
Feature	EPM7032AE	EPM7064AE	EPM7128AE	EPM7256AE	EPM7512AE
Usable gates	600	1,250	2,500	5,000	10,000
Macrocells	32	64	128	256	512
Logic array blocks	2	4	8	16	32
Maximum user I/O pins	36	68	100	164	212
t <sub>PD</sub> (ns)	4.5	4.5	5.0	5.5	7.5
t <sub>SU</sub> (ns)	2.9	2.8	3.3	3.9	5.6
t <sub>FSU</sub> (ns)	2.5	2.5	2.5	2.5	3.0
t <sub>CO1</sub> (ns)	3.0	3.1	3.4	3.5	4.7
f <sub>CNT</sub> (MHz)	227.3	222.2	192.3	172.4	116.3

## ...and More Features

- 4.5-ns pin-to-pin logic delays with counter frequencies of up to 227.3 MHz
- MultiVolt<sup>™</sup> I/O interface enables device core to run at 3.3 V, while I/O pins are compatible with 5.0-V, 3.3-V, and 2.5-V logic levels
- Pin counts ranging from 44 to 256 in a variety of thin quad flat pack (TQFP), plastic quad flat pack (PQFP), ball-grid array (BGA), spacesaving FineLine BGA<sup>™</sup>, and plastic J-lead chip carrier (PLCC) packages
- Supports hot-socketing in MAX 7000AE devices
- Programmable interconnect array (PIA) continuous routing structure for fast, predictable performance
- PCI-compatible
- Bus-friendly architecture, including programmable slew-rate control
- Open-drain output option
- Programmable macrocell registers with individual clear, preset, clock, and clock enable controls
- Programmable power-up states for macrocell registers in MAX 7000AE devices
- Programmable power-saving mode for 50% or greater power reduction in each macrocell
- Configurable expander product-term distribution, allowing up to 32 product terms per macrocell
- Programmable security bit for protection of proprietary designs
- 6 to 10 pin- or logic-driven output enable signals
- Two global clock signals with optional inversion
- Enhanced interconnect resources for improved routability
- Fast input setup times provided by a dedicated path from I/O pin to macrocell registers
- Programmable output slew-rate control
- Programmable ground pins

## Functional Description

The MAX 7000A architecture includes the following elements:

- Logic array blocks (LABs)
- Macrocells
- Expander product terms (shareable and parallel)
- Programmable interconnect array
- I/O control blocks

The MAX 7000A architecture includes four dedicated inputs that can be used as general-purpose inputs or as high-speed, global control signals (clock, clear, and two output enable signals) for each macrocell and I/O pin. Figure 1 shows the architecture of MAX 7000A devices.

#### Macrocells

MAX 7000A macrocells can be individually configured for either sequential or combinatorial logic operation. The macrocells consist of three functional blocks: the logic array, the product-term select matrix, and the programmable register. Figure 2 shows a MAX 7000A macrocell.



Combinatorial logic is implemented in the logic array, which provides five product terms per macrocell. The product-term select matrix allocates these product terms for use as either primary logic inputs (to the OR and XOR gates) to implement combinatorial functions, or as secondary inputs to the macrocell's register preset, clock, and clock enable control functions.

Two kinds of expander product terms ("expanders") are available to supplement macrocell logic resources:

- Shareable expanders, which are inverted product terms that are fed back into the logic array
- Parallel expanders, which are product terms borrowed from adjacent macrocells

The Altera development system automatically optimizes product-term allocation according to the logic requirements of the design.

### **Expander Product Terms**

Although most logic functions can be implemented with the five product terms available in each macrocell, more complex logic functions require additional product terms. Another macrocell can be used to supply the required logic resources. However, the MAX 7000A architecture also offers both shareable and parallel expander product terms that provide additional product terms directly to any macrocell in the same LAB. These expanders help ensure that logic is synthesized with the fewest possible logic resources to obtain the fastest possible speed.

### Shareable Expanders

Each LAB has 16 shareable expanders that can be viewed as a pool of uncommitted single product terms (one from each macrocell) with inverted outputs that feed back into the logic array. Each shareable expander can be used and shared by any or all macrocells in the LAB to build complex logic functions. A small delay ( $t_{SEXP}$ ) is incurred when shareable expanders are used. Figure 3 shows how shareable expanders can feed multiple macrocells.



Shareable expanders can be shared by any or all macrocells in an LAB.



Figure 5. MAX 7000A PIA Routing



While the routing delays of channel-based routing schemes in masked or FPGAs are cumulative, variable, and path-dependent, the MAX 7000A PIA has a predictable delay. The PIA makes a design's timing performance easy to predict.

## I/O Control Blocks

The I/O control block allows each I/O pin to be individually configured for input, output, or bidirectional operation. All I/O pins have a tri-state buffer that is individually controlled by one of the global output enable signals or directly connected to ground or  $V_{CC}$ . Figure 6 shows the I/O control block for MAX 7000A devices. The I/O control block has 6 or 10 global output enable signals that are driven by the true or complement of two output enable signals, a subset of the I/O pins, or a subset of the I/O macrocells.



For more information on using the Jam STAPL language, see *Application Note 88* (Using the Jam Language for ISP & ICR via an Embedded Processor) and *Application Note 122* (Using Jam STAPL for ISP & ICR via an Embedded *Processor*).

ISP circuitry in MAX 7000AE devices is compliant with the IEEE Std. 1532 specification. The IEEE Std. 1532 is a standard developed to allow concurrent ISP between multiple PLD vendors.

## **Programming Sequence**

During in-system programming, instructions, addresses, and data are shifted into the MAX 7000A device through the TDI input pin. Data is shifted out through the TDO output pin and compared against the expected data.

Programming a pattern into the device requires the following six ISP stages. A stand-alone verification of a programmed pattern involves only stages 1, 2, 5, and 6.

- 1. *Enter ISP*. The enter ISP stage ensures that the I/O pins transition smoothly from user mode to ISP mode. The enter ISP stage requires 1 ms.
- 2. *Check ID*. Before any program or verify process, the silicon ID is checked. The time required to read this silicon ID is relatively small compared to the overall programming time.
- 3. *Bulk Erase*. Erasing the device in-system involves shifting in the instructions to erase the device and applying one erase pulse of 100 ms.
- 4. *Program*. Programming the device in-system involves shifting in the address and data and then applying the programming pulse to program the EEPROM cells. This process is repeated for each EEPROM address.
- 5. *Verify.* Verifying an Altera device in-system involves shifting in addresses, applying the read pulse to verify the EEPROM cells, and shifting out the data for comparison. This process is repeated for each EEPROM address.
- 6. *Exit ISP*. An exit ISP stage ensures that the I/O pins transition smoothly from ISP mode to user mode. The exit ISP stage requires 1 ms.

## Programmable Speed/Power Control

MAX 7000A devices offer a power-saving mode that supports low-power operation across user-defined signal paths or the entire device. This feature allows total power dissipation to be reduced by 50% or more because most logic applications require only a small fraction of all gates to operate at maximum frequency.

The designer can program each individual macrocell in a MAX 7000A device for either high-speed (i.e., with the Turbo Bit<sup>TM</sup> option turned on) or low-power operation (i.e., with the Turbo Bit option turned off). As a result, speed-critical paths in the design can run at high speed, while the remaining paths can operate at reduced power. Macrocells that run at low power incur a nominal timing delay adder ( $t_{LPA}$ ) for the  $t_{LAD}$ ,  $t_{LAC}$ ,  $t_{IC}$ ,  $t_{EN}$ ,  $t_{SEXP}$ ,  $\mathbf{t}_{ACL}$ , and  $\mathbf{t_{CPPW}}$  parameters.

# Output Configuration

MAX 7000A device outputs can be programmed to meet a variety of system-level requirements.

## MultiVolt I/O Interface

The MAX 7000A device architecture supports the MultiVolt I/O interface feature, which allows MAX 7000A devices to connect to systems with differing supply voltages. MAX 7000A devices in all packages can be set for 2.5-V, 3.3-V, or 5.0-V I/O pin operation. These devices have one set of VCC pins for internal operation and input buffers (VCCINT), and another set for I/O output drivers (VCCIO).

The VCCIO pins can be connected to either a 3.3-V or 2.5-V power supply, depending on the output requirements. When the VCCIO pins are connected to a 2.5-V power supply, the output levels are compatible with 2.5-V systems. When the VCCIO pins are connected to a 3.3-V power supply, the output high is at 3.3 V and is therefore compatible with 3.3-V or 5.0-V systems. Devices operating with V<sub>CCIO</sub> levels lower than 3.0 V incur a slightly greater timing delay of  $t_{OD2}$  instead of  $t_{OD1}$ . Inputs can always be driven by 2.5-V, 3.3-V, or 5.0-V signals.

Table 12 describes the MAX 7000A MultiVolt I/O support.

Table 12. MAX 7000A MultiVolt I/O Support										
V <sub>CCIO</sub> Voltage Input Signal (V) Output Signal (V)										
	2.5	3.3	5.0	2.5	3.3	5.0				
2.5	~	~	~	$\checkmark$						
3.3	$\checkmark$	$\checkmark$	$\checkmark$		$\checkmark$	$\checkmark$				

Power Sequencing & Hot-Socketing	Because MAX 7000A devices can be used in a mixed-voltage environment, they have been designed specifically to tolerate any possible power-up sequence. The $\rm V_{CCIO}$ and $\rm V_{CCINT}$ power planes can be powered in any order.
	Signals can be driven into MAX 7000AE devices before and during power- up (and power-down) without damaging the device. Additionally, MAX 7000AE devices do not drive out during power-up. Once operating conditions are reached, MAX 7000AE devices operate as specified by the user.
	MAX 7000AE device I/O pins will not source or sink more than 300 $\mu A$ of DC current during power-up. All pins can be driven up to 5.75 V during hot-socketing, except the OE1 and GLCRn pins. The OE1 and GLCRn pins can be driven up to 3.6 V during hot-socketing. After V <sub>CCINT</sub> and V <sub>CCIO</sub> reach the recommended operating conditions, these two pins are 5.0-V tolerant.
	EPM7128A and EPM7256A devices do not support hot-socketing and may drive out during power-up.
Design Security	All MAX 7000A devices contain a programmable security bit that controls access to the data programmed into the device. When this bit is programmed, a design implemented in the device cannot be copied or retrieved. This feature provides a high level of design security because programmed data within EEPROM cells is invisible. The security bit that controls this function, as well as all other programmed data, is reset only when the device is reprogrammed.
Generic Testing	MAX 7000A devices are fully tested. Complete testing of each programmable EEPROM bit and all internal logic elements ensures 100% programming yield. AC test measurements are taken under conditions equivalent to those shown in Figure 9. Test patterns can be used and then erased during early stages of the production flow.

Tables 17 through 30 show EPM7032AE, EPM7064AE, EPM7128AE, EPM7256AE, EPM7512AE, EPM7128A, and EPM7256A timing information.

Table 1	7. EPM7032AE External Timi	ng Parameters	Note (	1)					
Symbol	Parameter	Conditions			Speed	Grade			Unit
			-	4	-	7	-1	0	
			Min	Мах	Min	Max	Min	Max	
t <sub>PD1</sub>	Input to non-registered output	C1 = 35 pF (2)		4.5		7.5		10	ns
t <sub>PD2</sub>	I/O input to non-registered output	C1 = 35 pF (2)		4.5		7.5		10	ns
t <sub>SU</sub>	Global clock setup time	(2)	2.9		4.7		6.3		ns
t <sub>H</sub>	Global clock hold time	(2)	0.0		0.0		0.0		ns
t <sub>FSU</sub>	Global clock setup time of fast input		2.5		3.0		3.0		ns
t <sub>FH</sub>	Global clock hold time of fast input		0.0		0.0		0.0		ns
t <sub>CO1</sub>	Global clock to output delay	C1 = 35 pF	1.0	3.0	1.0	5.0	1.0	6.7	ns
t <sub>CH</sub>	Global clock high time		2.0		3.0		4.0		ns
t <sub>CL</sub>	Global clock low time		2.0		3.0		4.0		ns
t <sub>ASU</sub>	Array clock setup time	(2)	1.6		2.5		3.6		ns
t <sub>AH</sub>	Array clock hold time	(2)	0.3		0.5		0.5		ns
t <sub>ACO1</sub>	Array clock to output delay	C1 = 35 pF (2)	1.0	4.3	1.0	7.2	1.0	9.4	ns
t <sub>ACH</sub>	Array clock high time		2.0		3.0		4.0		ns
t <sub>ACL</sub>	Array clock low time		2.0		3.0		4.0		ns
t <sub>CPPW</sub>	Minimum pulse width for clear and preset	(3)	2.0		3.0		4.0		ns
t <sub>CNT</sub>	Minimum global clock period	(2)		4.4		7.2		9.7	ns
f <sub>CNT</sub>	Maximum internal global clock frequency	(2), (4)	227.3		138.9		103.1		MHz
t <sub>ACNT</sub>	Minimum array clock period	(2)		4.4		7.2		9.7	ns
facnt	Maximum internal array clock frequency	(2), (4)	227.3		138.9		103.1		MHz

Symbol	Parameter	Conditions	Speed Grade						
			-	4	-	7		10	
			Min	Max	Min	Max	Min	Max	
t <sub>IN</sub>	Input pad and buffer delay			0.7		1.2		1.5	ns
t <sub>IO</sub>	I/O input pad and buffer delay			0.7		1.2		1.5	ns
t <sub>FIN</sub>	Fast input delay			2.3		2.8		3.4	ns
t <sub>SEXP</sub>	Shared expander delay			1.9		3.1		4.0	ns
t <sub>PEXP</sub>	Parallel expander delay			0.5		0.8		1.0	ns
t <sub>LAD</sub>	Logic array delay			1.5		2.5		3.3	ns
t <sub>LAC</sub>	Logic control array delay			0.6		1.0		1.2	ns
t <sub>IOE</sub>	Internal output enable delay			0.0		0.0		0.0	ns
t <sub>OD1</sub>	Output buffer and pad delay, slow slew rate = off $V_{CCIO} = 3.3 V$	C1 = 35 pF		0.8		1.3		1.8	ns
t <sub>OD2</sub>	Output buffer and pad delay, slow slew rate = off $V_{CCIO} = 2.5 V$	C1 = 35 pF (5)		1.3		1.8		2.3	ns
t <sub>OD3</sub>	Output buffer and pad delay, slow slew rate = on $V_{CCIO} = 2.5 V \text{ or } 3.3 V$	C1 = 35 pF		5.8		6.3		6.8	ns
t <sub>ZX1</sub>	Output buffer enable delay, slow slew rate = off $V_{CCIO} = 3.3 V$	C1 = 35 pF		4.0		4.0		5.0	ns
t <sub>ZX2</sub>	Output buffer enable delay, slow slew rate = off $V_{CCIO} = 2.5 V$	C1 = 35 pF (5)		4.5		4.5		5.5	ns
t <sub>ZX3</sub>	Output buffer enable delay, slow slew rate = on $V_{CCIO} = 3.3 V$	C1 = 35 pF		9.0		9.0		10.0	ns
t <sub>XZ</sub>	Output buffer disable delay	C1 = 5 pF		4.0		4.0		5.0	ns
t <sub>SU</sub>	Register setup time		1.3		2.0		2.8		ns
t <sub>H</sub>	Register hold time		0.6		1.0		1.3		ns
t <sub>FSU</sub>	Register setup time of fast input		1.0		1.5		1.5		ns
t <sub>FH</sub>	Register hold time of fast input		1.5		1.5		1.5		ns
t <sub>RD</sub>	Register delay			0.7		1.2		1.5	ns
t <sub>COMB</sub>	Combinatorial delay			0.6		1.0		1.3	ns

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Table 18. EPM7032AE Internal Timing Parameters (Part 2 of 2) Note (1)										
Symbol	Parameter	Conditions			Speed	Grade			Unit	
			-	-4		-7		10		
			Min	Max	Min	Max	Min	Max		
t <sub>IC</sub>	Array clock delay			1.2		2.0		2.5	ns	
t <sub>EN</sub>	Register enable time			0.6		1.0		1.2	ns	
t <sub>GLOB</sub>	Global control delay			0.8		1.3		1.9	ns	
t <sub>PRE</sub>	Register preset time			1.2		1.9		2.6	ns	
t <sub>CLR</sub>	Register clear time			1.2		1.9		2.6	ns	
t <sub>PIA</sub>	PIA delay	(2)		0.9		1.5		2.1	ns	
t <sub>LPA</sub>	Low-power adder	(6)		2.5		4.0		5.0	ns	

Symbol	Parameter	Conditions	Speed Grade							
			-	4		7	-	10		
			Min	Max	Min	Max	Min	Max		
t <sub>IN</sub>	Input pad and buffer delay			0.6		1.1		1.4	ns	
t <sub>IO</sub>	I/O input pad and buffer delay			0.6		1.1		1.4	ns	
t <sub>FIN</sub>	Fast input delay			2.5		3.0		3.7	ns	
t <sub>SEXP</sub>	Shared expander delay			1.8		3.0		3.9	ns	
t <sub>PEXP</sub>	Parallel expander delay			0.4		0.7		0.9	ns	
t <sub>LAD</sub>	Logic array delay			1.5		2.5		3.2	ns	
t <sub>LAC</sub>	Logic control array delay			0.6		1.0		1.2	ns	
t <sub>IOE</sub>	Internal output enable delay			0.0		0.0		0.0	ns	
t <sub>OD1</sub>	Output buffer and pad delay, slow slew rate = off $V_{CCIO} = 3.3 V$	C1 = 35 pF		0.8		1.3		1.8	ns	
t <sub>OD2</sub>	Output buffer and pad delay, slow slew rate = off $V_{CCIO} = 2.5 V$	C1 = 35 pF (5)		1.3		1.8		2.3	ns	
t <sub>OD3</sub>	Output buffer and pad delay, slow slew rate = on $V_{CCIO} = 2.5 V \text{ or } 3.3 V$	C1 = 35 pF		5.8		6.3		6.8	ns	
t <sub>ZX1</sub>	Output buffer enable delay, slow slew rate = off $V_{CCIO} = 3.3 V$	C1 = 35 pF		4.0		4.0		5.0	ns	
t <sub>ZX2</sub>	Output buffer enable delay, slow slew rate = off $V_{CCIO} = 2.5 V$	C1 = 35 pF (5)		4.5		4.5		5.5	ns	
t <sub>ZX3</sub>	Output buffer enable delay, slow slew rate = on $V_{CCIO} = 3.3 V$	C1 = 35 pF		9.0		9.0		10.0	ns	
t <sub>XZ</sub>	Output buffer disable delay	C1 = 5 pF		4.0		4.0		5.0	ns	
t <sub>SU</sub>	Register setup time		1.3		2.0		2.9		ns	
t <sub>H</sub>	Register hold time		0.6		1.0		1.3		ns	
t <sub>FSU</sub>	Register setup time of fast input		1.0		1.5		1.5		ns	
t <sub>FH</sub>	Register hold time of fast input		1.5		1.5		1.5		ns	
t <sub>RD</sub>	Register delay			0.7		1.2		1.6	ns	
t <sub>COMB</sub>	Combinatorial delay			0.6		0.9		1.3	ns	
t <sub>IC</sub>	Array clock delay			1.2		1.9		2.5	ns	

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Table 20. EPM7064AE Internal Timing Parameters (Part 2 of 2) Note (1)										
Symbol	Parameter	Conditions			Unit					
			-,	-4 -7 -10				10		
			Min	Max	Min	Max	Min	Max		
t <sub>EN</sub>	Register enable time			0.6		1.0		1.2	ns	
t <sub>GLOB</sub>	Global control delay			1.0		1.5		2.2	ns	
t <sub>PRE</sub>	Register preset time			1.3		2.1		2.9	ns	
t <sub>CLR</sub>	Register clear time			1.3		2.1		2.9	ns	
t <sub>PIA</sub>	PIA delay	(2)		1.0		1.7		2.3	ns	
t <sub>LPA</sub>	Low-power adder	(6)		3.5		4.0		5.0	ns	

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Table 22	Table 22. EPM7128AE Internal Timing Parameters (Part 2 of 2) Note (1)										
Symbol	Parameter	Conditions			Speed	Grade			Unit		
			-	-5		7	-10				
			Min	Max	Min	Max	Min	Max			
t <sub>EN</sub>	Register enable time			0.7		1.0		1.3	ns		
t <sub>GLOB</sub>	Global control delay			1.1		1.6		2.0	ns		
t <sub>PRE</sub>	Register preset time			1.4		2.0		2.7	ns		
t <sub>CLR</sub>	Register clear time			1.4		2.0		2.7	ns		
t <sub>PIA</sub>	PIA delay	(2)		1.4		2.0		2.6	ns		
t <sub>LPA</sub>	Low-power adder	(6)		4.0		4.0		5.0	ns		

Symbol	Parameter	Conditions	Speed Grade							
			-	7	-'	10		12		
			Min	Max	Min	Max	Min	Max	1	
t <sub>IN</sub>	Input pad and buffer delay			0.7		0.9		1.0	ns	
t <sub>IO</sub>	I/O input pad and buffer delay			0.7		0.9		1.0	ns	
t <sub>FIN</sub>	Fast input delay			3.1		3.6		4.1	ns	
t <sub>SEXP</sub>	Shared expander delay			2.7		3.5		4.4	ns	
t <sub>PEXP</sub>	Parallel expander delay			0.4		0.5		0.6	ns	
t <sub>LAD</sub>	Logic array delay			2.2		2.8		3.5	ns	
t <sub>LAC</sub>	Logic control array delay			1.0		1.3		1.7	ns	
t <sub>IOE</sub>	Internal output enable delay			0.0		0.0		0.0	ns	
t <sub>OD1</sub>	Output buffer and pad delay, slow slew rate = off $V_{CCIO} = 3.3 V$	C1 = 35 pF		1.0		1.5		1.7	ns	
t <sub>OD2</sub>	Output buffer and pad delay, slow slew rate = off $V_{CCIO} = 2.5 V$	C1 = 35 pF (5)		1.5		2.0		2.2	ns	
t <sub>OD3</sub>	Output buffer and pad delay, slow slew rate = on $V_{CCIO} = 2.5 V \text{ or } 3.3 V$	C1 = 35 pF		6.0		6.5		6.7	ns	
t <sub>ZX1</sub>	Output buffer enable delay, slow slew rate = off $V_{CCIO} = 3.3 V$	C1 = 35 pF		4.0		5.0		5.0	ns	
t <sub>ZX2</sub>	Output buffer enable delay, slow slew rate = off $V_{CCIO} = 2.5 V$	C1 = 35 pF (5)		4.5		5.5		5.5	ns	
t <sub>ZX3</sub>	Output buffer enable delay, slow slew rate = on $V_{CCIO} = 3.3 V$	C1 = 35 pF		9.0		10.0		10.0	ns	
t <sub>XZ</sub>	Output buffer disable delay	C1 = 5 pF		4.0		5.0		5.0	ns	
t <sub>SU</sub>	Register setup time		2.1		3.0		3.5		ns	
t <sub>H</sub>	Register hold time		0.6		0.8		1.0		ns	
t <sub>FSU</sub>	Register setup time of fast input		1.6		1.6		1.6		ns	
t <sub>FH</sub>	Register hold time of fast input		1.4		1.4		1.4		ns	
t <sub>RD</sub>	Register delay			1.3		1.7		2.1	ns	
t <sub>COMB</sub>	Combinatorial delay			0.6		0.8		1.0	ns	

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Table 2	Table 28. EPM7128A Internal Timing Parameters (Part 1 of 2) Note (1)											
Symbol	Parameter	Conditions				Speed	Grade				Unit	
			-	6	-	7	-1	10	-1	12	1	
			Min	Мах	Min	Max	Min	Мах	Min	Max		
t <sub>IN</sub>	Input pad and buffer delay			0.6		0.7		0.9		1.1	ns	
t <sub>IO</sub>	I/O input pad and buffer delay			0.6		0.7		0.9		1.1	ns	
t <sub>FIN</sub>	Fast input delay			2.7		3.1		3.6		3.9	ns	
t <sub>SEXP</sub>	Shared expander delay			2.5		3.2		4.3		5.1	ns	
t <sub>PEXP</sub>	Parallel expander delay			0.7		0.8		1.1		1.3	ns	
t <sub>LAD</sub>	Logic array delay			2.4		3.0		4.1		4.9	ns	
t <sub>LAC</sub>	Logic control array delay			2.4		3.0		4.1		4.9	ns	
t <sub>IOE</sub>	Internal output enable delay			0.0		0.0		0.0		0.0	ns	
t <sub>OD1</sub>	Output buffer and pad delay, slow slew rate = off $V_{CCIO}$ = 3.3 V	C1 = 35 pF		0.4		0.6		0.7		0.9	ns	
t <sub>OD2</sub>	Output buffer and pad delay, slow slew rate = off $V_{CCIO} = 2.5 V$	C1 = 35 pF (5)		0.9		1.1		1.2		1.4	ns	
t <sub>OD3</sub>	Output buffer and pad delay, slow slew rate = on $V_{CCIO} = 2.5$ V or 3.3 V	C1 = 35 pF		5.4		5.6		5.7		5.9	ns	
t <sub>ZX1</sub>	Output buffer enable delay, slow slew rate = off $V_{CCIO} = 3.3 \text{ V}$	C1 = 35 pF		4.0		4.0		5.0		5.0	ns	
t <sub>ZX2</sub>	Output buffer enable delay, slow slew rate = off $V_{CCIO} = 2.5 V$	C1 = 35 pF (5)		4.5		4.5		5.5		5.5	ns	
t <sub>ZX3</sub>	Output buffer enable delay, slow slew rate = on $V_{CCIO} = 3.3 V$	C1 = 35 pF		9.0		9.0		10.0		10.0	ns	
t <sub>XZ</sub>	Output buffer disable delay	C1 = 5 pF		4.0		4.0		5.0		5.0	ns	
t <sub>SU</sub>	Register setup time		1.9		2.4		3.1		3.8		ns	
t <sub>H</sub>	Register hold time		1.5		2.2		3.3		4.3		ns	
t <sub>FSU</sub>	Register setup time of fast input		0.8		1.1		1.1		1.1		ns	
t <sub>FH</sub>	Register hold time of fast input		1.7		1.9		1.9		1.9		ns	

Figure 13 shows the typical supply current versus frequency for MAX 7000A devices.





#### EPM7128A & EPM7128AE



Figure 17. 100-Pin TQFP Package Pin-Out Diagram

Package outline not drawn to scale.



Figure 18. 100-Pin FineLine BGA Package Pin-Out Diagram



## Figure 21. 208-Pin PQFP Package Pin-Out Diagram

Package outline not drawn to scale.



### Figure 22. 256-Pin BGA Package Pin-Out Diagram

Package outline not drawn to scale.

